M24512

512 Kbit Serial I²C Bus EEPROM

- Two Wire I^{2}C Serial Interface Supports 400 kHz Protocol
- Single Supply Voltage:
  - 4.5V to 5.5V for M24512
  - 2.5V to 5.5V for M24512-W
  - 1.8V to 3.6V for M24512-S
- Write Control Input
- BYTE and PAGE WRITE (up to 128 Bytes)
- RANDOM and SEQUENTIAL READ Modes
- Self-Timed Programming Cycle
- Automatic Address Incrementing
- Enhanced ESD/Latch-Up Behavior
- More than 100,000 Erase/Write Cycles
- More than 40 Year Data Retention

DESCRIPTION

These I^{2}C-compatible electrically erasable programmable memory (EEPROM) devices are organised as 64Kx8 bits, and operate down to 2.5 V (for the -W version), and down to 1.8 V (for the -S version).

These devices are compatible with the I^{2}C memory protocol. This is a two wire serial interface that uses a bi-directional data bus and serial clock. The devices carry a built-in 4-bit Device Type Identifier code (1010) in accordance with the I^{2}C bus definition.

PDIP8 (BN)
0.25 mm frame

SO8 (MW)
200 mil width

LGA8 (LA)

Table 1. Signal Names

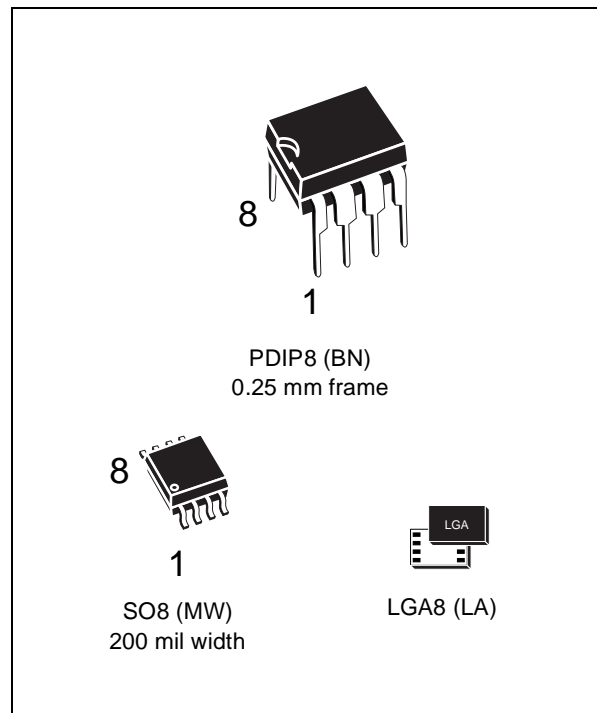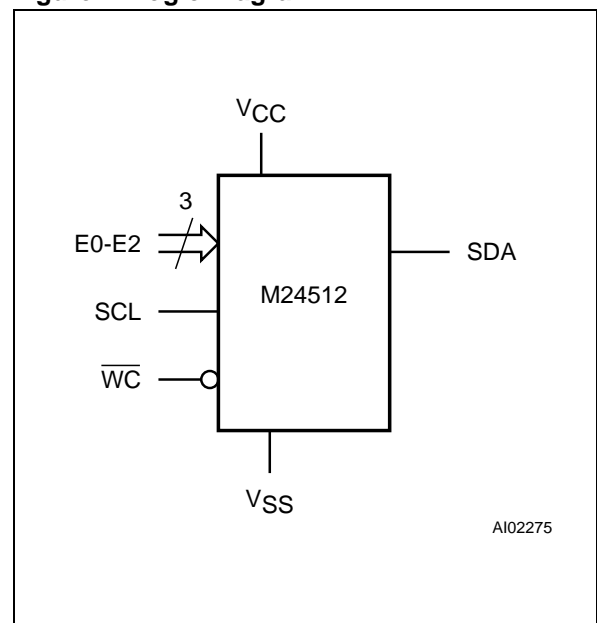| E0, E1, E2	Chip Enable
SDA	Serial Data
SCL	Serial Clock
$\overline{WC}$	Write Control
V$_{CC}$	Supply Voltage
V$_{SS}$	Ground

Figure 1. Logic Diagram

Figure 2A. DIP Connections
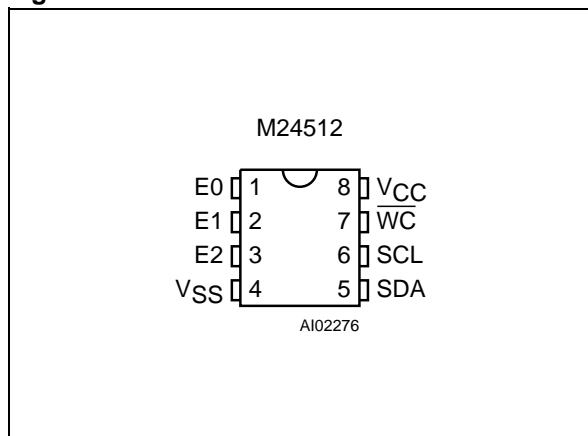
Figure 2C. SO8 Connections
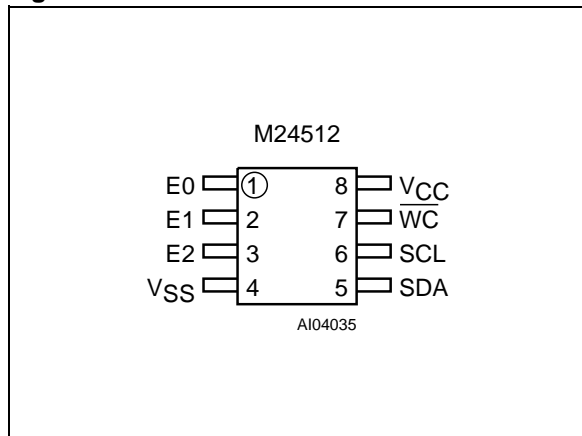
Figure 2B. LGA Connections
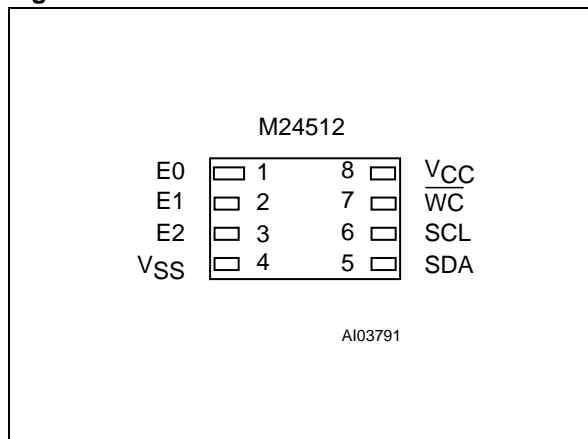
Table 2. Absolute Maximum Ratings [1]

Symbol	Parameter		Value	Unit
T_A	Ambient Operating Temperature		–40 to 125	°C
T_{STG}	Storage Temperature		–65 to 150	°C
T_{LEAD}	Lead Temperature during Soldering	PDIP: 10 seconds	260	°C
		SO: 20 seconds (max) [2]	235	
V_{IO}	Input or Output range		–0.6 to 6.5	V
V_{CC}	Supply Voltage		–0.3 to 6.5	V
V_{ESD}	Electrostatic Discharge Voltage (Human Body model) [3]		4000	V

Note: 1. Except for the rating "Operating Temperature Range", stresses above those listed in the Table "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the ST SURE Program and other relevant quality documents.

2. IPC/JEDEC J-STD-020A

3. JEDEC Std JESD22-A114A (C1=100 pF, R1=1500 Ω, R2=500 Ω)

The device behaves as a slave in the I^2C protocol, with all memory operations synchronized by the serial clock. Read and Write operations are initiated by a Start condition, generated by the bus master. The Start condition is followed by a Device Select Code and R$\overline{W}$ bit (as described in Table 3), terminated by an acknowledge bit.

When writing data to the memory, the device inserts an acknowledge bit during the 9th bit time, following the bus master's 8-bit transmission. When data is read by the bus master, the bus master acknowledges the receipt of the data byte in the same way. Data transfers are terminated by a Stop condition after an Ack for Write, and after a NoAck for Read.

Power On Reset: V_{CC} Lock-Out Write Protect

In order to prevent data corruption and inadvertent Write operations during Power-up, a Power On Reset (POR) circuit is included. The internal reset is held active until V_{CC} has reached the POR threshold value, and all operations are disabled – the device will not respond to any command. In the same way, when V_{CC} drops from the operating voltage, below the POR threshold value, all operations are disabled and the device will not respond to any command. A stable and valid V_{CC} must be applied before applying any logic signal.

SIGNAL DESCRIPTION
Serial Clock (SCL)

This input signal is used to strobe all data in and out of the device. In applications where this signal is used by slave devices to synchronize the bus to a slower clock, the bus master must have an open drain output, and a pull-up resistor must be connected from Serial Clock (SCL) to V_{CC}. (Figure 3 indicates how the value of the pull-up resistor can be calculated). In most applications, though, this method of synchronization is not employed, and so the pull-up resistor is not necessary, provided that the bus master has a push-pull (rather than open drain) output.

Serial Data (SDA)

This bi-directional signal is used to transfer data in or out of the device. It is an open drain output that may be wire-OR'ed with other open drain or open collector signals on the bus. A pull up resistor must be connected from Serial Data (SDA) to V_{CC}. (Figure 3 indicates how the value of the pull-up resistor can be calculated).

Chip Enable (E0, E1, E2)

These input signals are used to set the value that is to be looked for on the three least significant bits (b3, b2, b1) of the 7-bit Device Select Code. These inputs must be tied to V_{CC} or V_{SS}, to establish the Device Select Code. When unconnected, the Chip Enable (E2, E1, E0) signals are internally read as V_{IL} (see Tables 7 and 8).

Write Control ($\overline{WC}$)

This input signal is useful for protecting the entire contents of the memory from inadvertent write operations. Write operations are disabled to the entire memory array when Write Control ($\overline{WC}$) is driven High. When unconnected, the signal is internally read as V_{IL}, and Write operations are allowed.

When Write Control ($\overline{WC}$) is driven High, Device Select and Address bytes are acknowledged, Data bytes are not acknowledged.

Figure 3. Maximum R_L Value versus Bus Capacitance (C_{BUS}) for an I^2C Bus
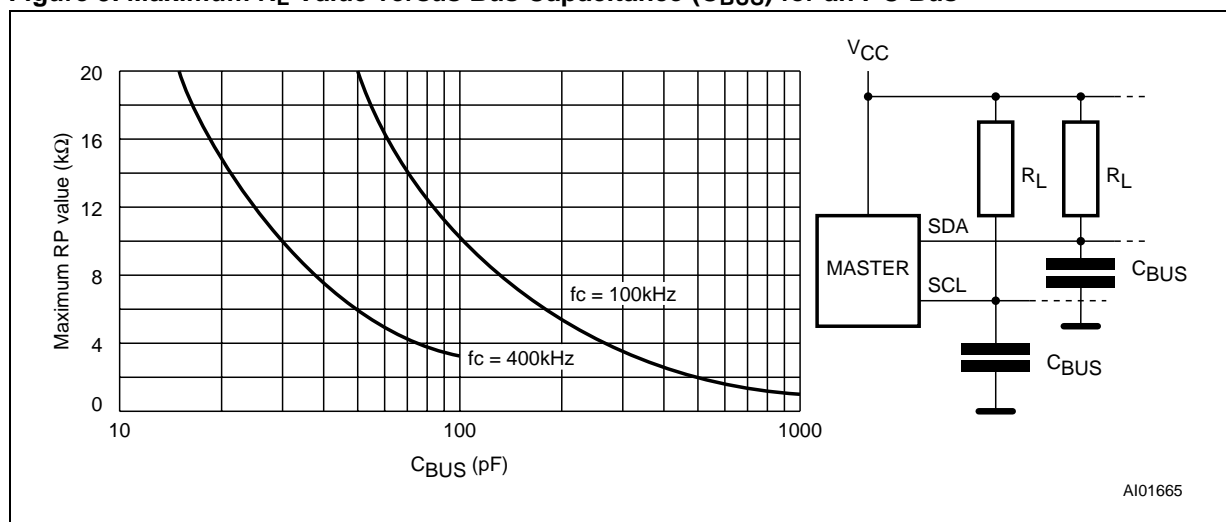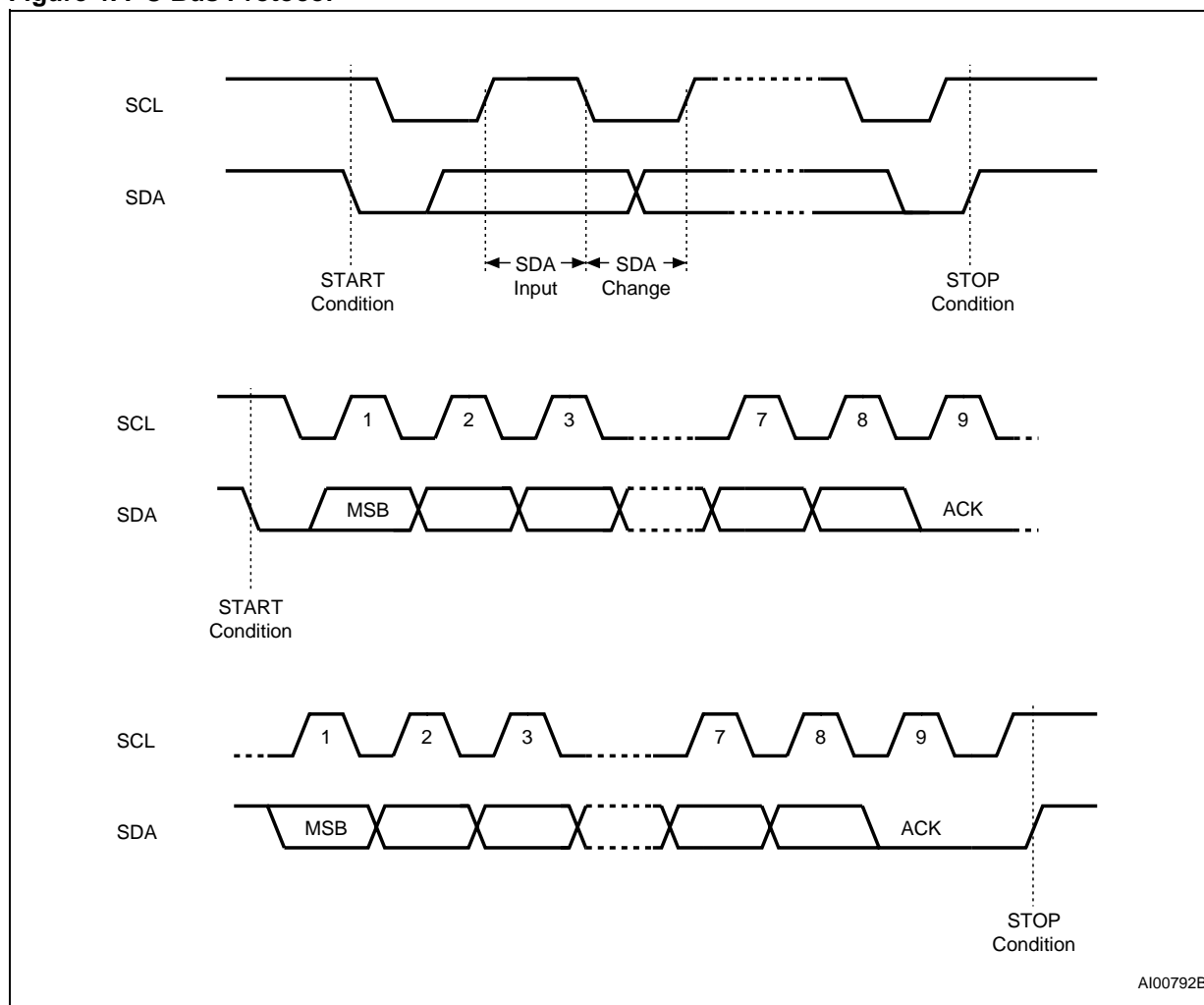

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Figure 4. I²C Bus Protocol

DEVICE OPERATION

The device supports the I²C protocol. This is summarized in Figure 4. Any device that sends data on to the bus is defined to be a transmitter, and any device that reads the data to be a receiver. The device that controls the data transfer is known as the bus master, and the other as the slave device. A data transfer can only be initiated by the bus master, which will also provide the serial clock for synchronization. The M24512 device is always a slave in all communication.

Start Condition

Start is identified by a falling edge of Serial Data (SDA) while Serial Clock (SCL) is stable in the High state. A Start condition must precede any data transfer command. The device continuously monitors (except during a Write cycle) Serial Data (SDA) and Serial Clock (SCL) for a Start condition, and will not respond unless one is given.

Stop Condition

Stop is identified by a rising edge of Serial Data (SDA) while Serial Clock (SCL) is stable and driven High. A Stop condition terminates communication between the device and the bus master. A Read command that is followed by NoAck can be followed by a Stop condition to force the device into the Stand-by mode. A Stop condition at the end of a Write command triggers the internal EEPROM Write cycle.

Acknowledge Bit (ACK)

The acknowledge bit is used to indicate a successful byte transfer. The bus transmitter, whether it be bus master or slave device, releases Serial Data (SDA) after sending eight bits of data. During the 9th clock pulse period, the receiver pulls Serial Data (SDA) Low to acknowledge the receipt of the eight data bits.

Table 3. Device Select Code [1]

	Device Type Identifier				Chip Enable Address			R$\overline{W}$
	b7	b6	b5	b4	b3	b2	b1	b0
Device Select Code	1	0	1	0	E2	E1	E0	R$\overline{W}$

Note: 1. The most significant bit, b7, is sent first.

Data Input

During data input, the device samples Serial Data (SDA) on the rising edge of Serial Clock (SCL). For correct device operation, Serial Data (SDA) must be stable during the rising edge of Serial Clock (SCL), and the Serial Data (SDA) signal must change *only* when Serial Clock (SCL) is driven Low.

Memory Addressing

To start communication between the bus master and the slave device, the bus master must initiate a Start condition. Following this, the bus master sends the Device Select Code, shown in Table 3 (on Serial Data (SDA), most significant bit first).

The Device Select Code consists of a 4-bit Device Type Identifier, and a 3-bit Chip Enable "Address" (E2, E1, E0). To address the memory array, the 4-bit Device Type Identifier is 1010b.

Up to eight memory devices can be connected on a single I^{2}C bus. Each one is given a unique 3-bit code on the Chip Enable (E0, E1, E2) inputs. When the Device Select Code is received on Serial Data (SDA), the device only responds if the Chip Enable Address is the same as the value on the Chip Enable (E0, E1, E2) inputs.

The 8th bit is the Read/$\overline{Write}$ bit (R$\overline{W}$). This bit is set to 1 for Read and 0 for Write operations.

If a match occurs on the Device Select code, the corresponding device gives an acknowledgment on Serial Data (SDA) during the 9th bit time. If the device does not match the Device Select code, it deselects itself from the bus, and goes into Stand-by mode.

Table 4. Most Significant Byte

b15	b14	b13	b12	b11	b10	b9	b8

Table 5. Least Significant Byte

b7	b6	b5	b4	b3	b2	b1	b0

Write Operations

Following a Start condition the bus master sends a Device Select Code with the R$\overline{W}$ bit reset to 0. The device acknowledges this, as shown in Figure 6, and waits for two address bytes. The device responds to each address byte with an acknowledge bit, and then waits for the data byte.

Writing to the memory may be inhibited if Write Control ($\overline{WC}$) is driven High. Any Write instruction with Write Control ($\overline{WC}$) driven High (during a period of time from the Start condition until the end of the two address bytes) will not modify the memory contents, and the accompanying data bytes are *not* acknowledged, as shown in Figure 5.

Each data byte in the memory has a 16-bit (two byte wide) address. The Most Significant Byte (Table 4) is sent first, followed by the Least Significant Byte (Table 5). Bits b15 to b0 form the address of the byte in memory.

When the bus master generates a Stop condition immediately after the Ack bit (in the "10th bit" time slot), either at the end of a Byte Write or a Page Write, the internal memory Write cycle is triggered.

Table 6. Operating Modes

Mode	R$\overline{W}$ bit	$\overline{WC}$ [1]	Bytes	Initial Sequence
Current Address Read	1	X	1	START, Device Select, R$\overline{W}$ = 1
Random Address Read	0	X	1	START, Device Select, R$\overline{W}$ = 0, Address
	1	X		reSTART, Device Select, R$\overline{W}$ = 1
Sequential Read	1	X	$\geq$ 1	Similar to Current or Random Address Read
Byte Write	0	V$_{IL}$	1	START, Device Select, R$\overline{W}$ = 0
Page Write	0	V$_{IL}$	$\leq$ 128	START, Device Select, R$\overline{W}$ = 0

Note: 1. X = V$_{IH}$ or V$_{IL}$.

Figure 5. Write Mode Sequences with $\overline{WC}$=1 (data write inhibited)

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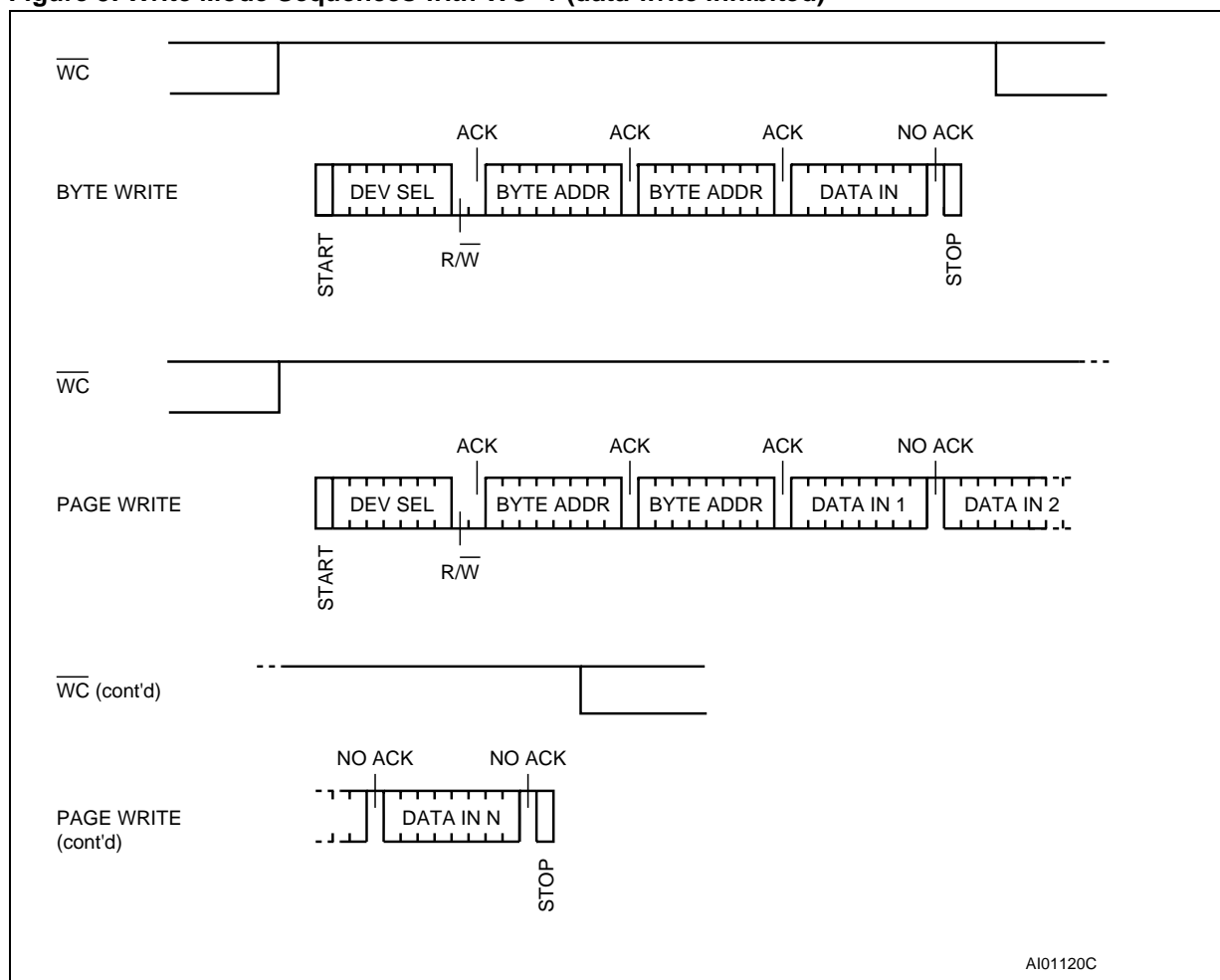
A Stop condition at any other time slot does not trigger the internal Write cycle.

During the internal Write cycle, Serial Data (SDA) is disabled internally, and the device does not respond to any requests.

Byte Write

After the Device Select code and the address bytes, the bus master sends one data byte. If the addressed location is Write-protected, by Write Control ($\overline{WC}$) being driven High, the device replies with NoAck, and the location is not modified. If, instead, the addressed location is not Write-protected, the device replies with Ack. The bus master terminates the transfer by generating a Stop condition, as shown in Figure 6.

Page Write

The Page Write mode allows up to 128 bytes to be written in a single Write cycle, provided that they are all located in the same 'row' in the memory: that is, the most significant memory address bits (b15-b7) are the same. If more bytes are sent than will fit up to the end of the row, a condition known as 'roll-over' occurs. This should be avoided, as data starts to become overwritten in an implementation dependent way.

The bus master sends from 1 to 128 bytes of data, each of which is acknowledged by the device if Write Control ($\overline{WC}$) is Low. If Write Control ($\overline{WC}$) is High, the contents of the addressed memory location are not modified, and each data byte is followed by a NoAck. After each byte is transferred, the internal byte address counter (the 7 least significant address bits only) is incremented. The transfer is terminated by the bus master generating a Stop condition.

Minimizing System Delays by Polling On ACK

During the internal Write cycle, the device disconnects itself from the bus, and writes a copy of the data from its internal latches to the memory

Figure 6. Write Mode Sequences with $\overline{WC}$=0 (data write enabled)

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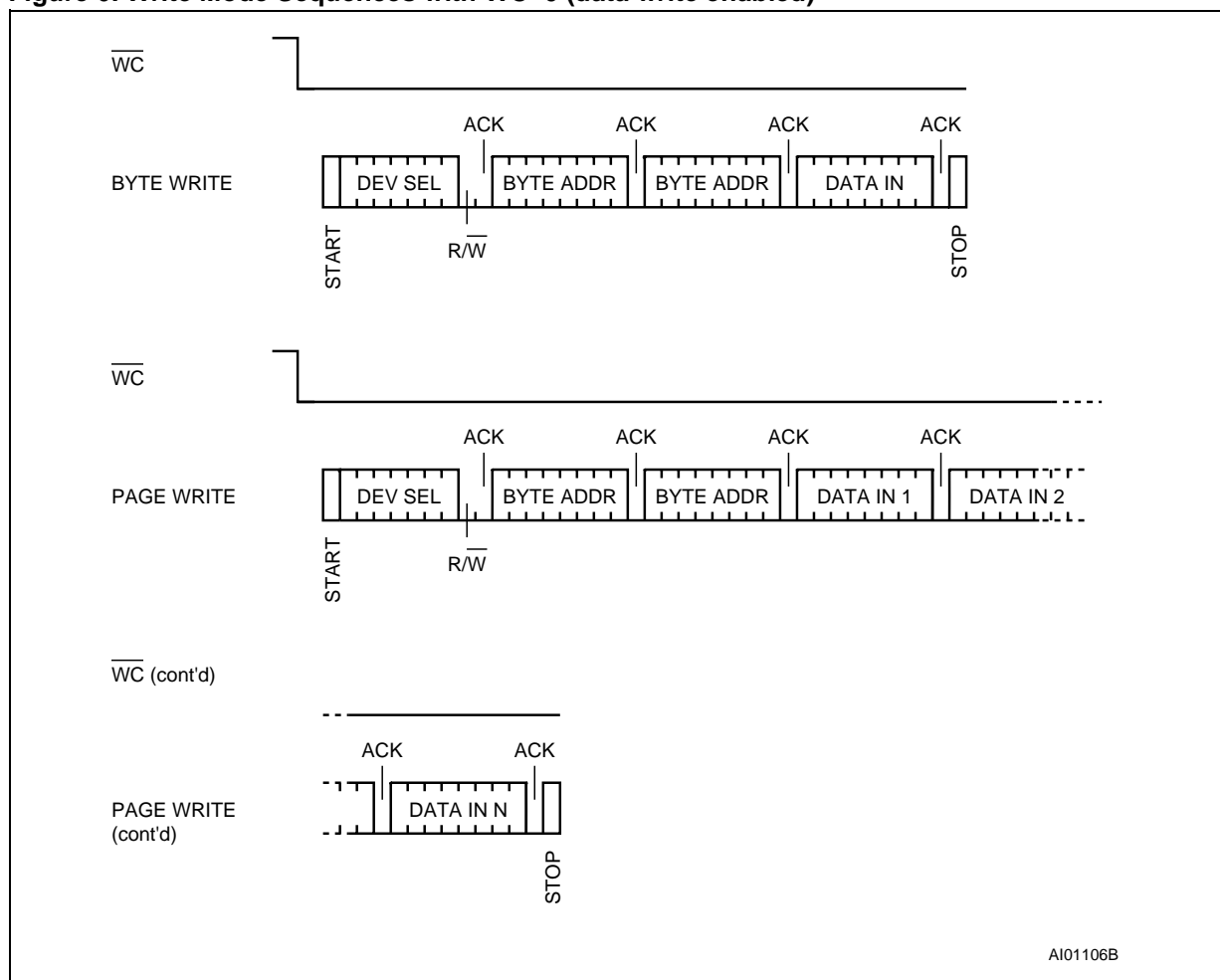
cells. The maximum Write time (t_W) is shown in Table 9, but the typical time is shorter. To make use of this, a polling sequence can be used by the bus master.

The sequence, as shown in Figure 7, is:

– Initial condition: a Write cycle is in progress.

– Step 1: the bus master issues a Start condition followed by a Device Select Code (the first byte of the new instruction).

– Step 2: if the device is busy with the internal Write cycle, no Ack will be returned and the bus master goes back to Step 1. If the device has terminated the internal Write cycle, it responds with an Ack, indicating that the device is ready to receive the second part of the instruction (the first byte of this instruction having been sent during Step 1).

Read Operations

Read operations are performed independently of the state of the Write Control ($\overline{WC}$) signal.

Random Address Read

A dummy Write is performed to load the address into the address counter (as shown in Figure 8) but *without* sending a Stop condition. Then, the bus master sends another Start condition, and repeats the Device Select Code, with the R$\overline{W}$ bit set to 1. The device acknowledges this, and outputs the contents of the addressed byte. The bus master must *not* acknowledge the byte, and terminates the transfer with a Stop condition.

Current Address Read

The device has an internal address counter which is incremented each time a byte is read. For the Current Address Read operation, following a Start condition, the bus master only sends a Device Select Code with the R$\overline{W}$ bit set to 1. The device acknowledges this, and outputs the byte

Figure 7. Write Cycle Polling Flowchart using ACK


```
                    ┌─────────────────┐
                    │  WRITE Cycle    │
                    │  in Progress    │
                    └────────┬────────┘
                             │
                    ┌────────▼────────┐
          ┌────────▶│ START Condition │
          │         └────────┬────────┘
          │                  │
          │         ┌────────▼────────┐
          │         │ DEVICE SELECT   │
          │         │ with RW = 0     │
          │         └────────┬────────┘
          │                  │
          │            ┌─────▼─────┐
          │     NO     │   ACK     │
          └────────────│  Returned │
                       └─────┬─────┘
                             │ YES
```

First byte of instruction
with RW = 0 already
decoded by the device

```
                 ┌─────────────┐
        NO       │   Next      │      YES
   ┌─────────────│ Operation is│──────────────┐
   │             │ Addressing  │              │
   │             │ the Memory  │              │
   │             └─────────────┘              │
   │                                 ┌────────▼────────┐
   │                                 │ Send Address    │
┌──▼──────┐                          │ and Receive ACK │
│ ReSTART │                          └────────┬────────┘
└──┬──────┘                                   │
   │                                    ┌─────▼─────┐
┌──▼──────┐                  NO         │   START   │   YES
│  STOP   │              ┌──────────────│ Condition │──────────┐
└─────────┘              │              └───────────┘          │
                ┌────────▼────────┐           ┌────────────────▼─┐
                │ DATA for the    │           │ DEVICE SELECT    │
                │ WRITE Operation │           │ with RW = 1      │
                └────────┬────────┘           └────────┬─────────┘
                         ┊                             ┊
                ┌────────▼────────┐           ┌────────▼────────┐
                │ Continue the    │           │ Continue the    │
                │ WRITE Operation │           │ Random READ     │
                └─────────────────┘           │ Operation       │
                                              └─────────────────┘
```

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addressed by the internal address counter. The counter is then incremented. The bus master terminates the transfer with a Stop condition, as shown in Figure 8, *without* acknowledging the byte.

Sequential Read

This operation can be used after a Current Address Read or a Random Address Read. The bus master *does* acknowledge the data byte output, and sends additional clock pulses so that the device continues to output the next byte in sequence. To terminate the stream of bytes, the bus master must *not* acknowledge the last byte, and *must* generate a Stop condition, as shown in Figure 8.

The output data comes from consecutive addresses, with the internal address counter automatically incremented after each byte output. After the last memory address, the address

counter 'rolls-over', and the device continues to output data from memory address 00h.

Acknowledge in Read Mode

For all Read commands, the device waits, after each byte read, for an acknowledgment during the 9th bit time. If the bus master does not drive Serial Data (SDA) Low during this time, the device terminates the data transfer and switches to its Stand-by mode.

Figure 8. Read Mode Sequences
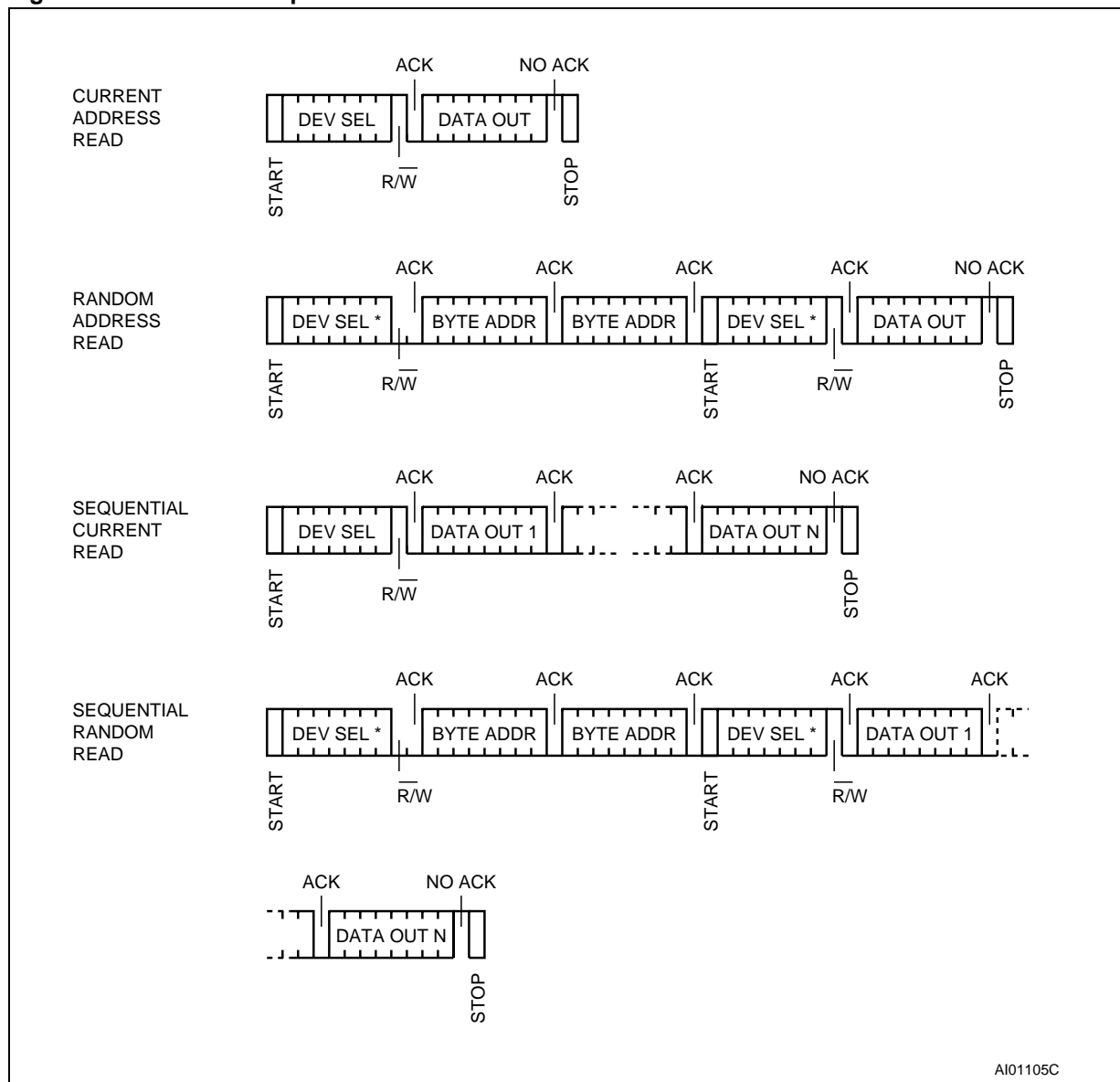
Note: 1. The seven most significant bits of the Device Select Code of a Random Read (in the 1st and 4th bytes) must be identical.

Table 7. DC Characteristics
$(T_A = 0$ to 70 °C or –40 to 85 °C; $V_{CC} = 4.5$ to 5.5 V or 2.5 to 5.5 V)
$(T_A = 0$ to 70 °C or –20 to 85 °C; $V_{CC} = 1.8$ to 3.6 V)

Symbol	Parameter		Test Condition	Min.	Max.	Unit
I_{LI}	Input Leakage Current (SCL, SDA)		$V_{IN} = V_{SS}$ or V_{CC}		± 2	µA
I_{LI}	Input Leakage Current (E2, E1, E0, $\overline{WC}$)		$V_{IN} = V_{SS}$		± 5	µA
I_{LO}	Output Leakage Current		$V_{OUT} = V_{SS}$ or V_{CC}, SDA in Hi-Z		± 2	µA
I_{CC}	Supply Current		$V_{CC}=5V$, $f_c=400kHz$ (rise/fall time < 30ns)		2	mA
		-W series:	$V_{CC} =2.5V$, $f_c=400kHz$ (rise/fall time < 30ns)		1	mA
		-S series:	$V_{CC}=1.8V$, $f_c=400kHz$ (rise/fall time < 30ns)		0.8[1]	mA
I_{CC1}	Supply Current (Stand-by)		$V_{IN} = V_{SS}$ or V_{CC}, $V_{CC} = 5$ V		10	µA
		-W series:	$V_{IN} = V_{SS}$ or V_{CC}, $V_{CC} = 2.5$ V		2	µA
		-S series:	$V_{IN} = V_{SS}$ or V_{CC}, $V_{CC} = 1.8$ V		1[1]	µA
V_{IL}	Input Low Voltage			– 0.3	$0.3V_{CC}$	V
V_{IH}	Input High Voltage			$0.7V_{CC}$	$V_{CC}+1$	V
V_{OL}	Output Low Voltage		$I_{OL} = 3$ mA, $V_{CC} = 5$ V		0.4	V
		-W series:	$I_{OL} = 2.1$ mA, $V_{CC} = 2.5$ V		0.4	V
		-S series:	$I_{OL} = 0.15$ mA, $V_{CC} = 1.8$ V		0.2[1]	V

Note: 1. This is preliminary data.

Table 8. Input Parameters[1] $(T_A = 25$ °C, f = 400 kHz)

Symbol	Parameter	Test Condition	Min.	Max.	Unit
C_{IN}	Input Capacitance (SDA)			8	pF
C_{IN}	Input Capacitance (other pins)			6	pF
Z_L	Input Impedance (E2, E1, E0, $\overline{WC}$)	$V_{IN} \leq V_{IL}$	50	300	kΩ
Z_H	Input Impedance (E2, E1, E0, $\overline{WC}$)	$V_{IN} \geq V_{IH}$	500		kΩ
t_{NS}	Pulse width ignored (Input Filter on SCL and SDA)	Single glitch		200	ns

Note: 1. Sampled only, not 100% tested.

Table 9. AC Characteristics

Symbol	Alt.	Parameter	M24512						Unit
			V_{CC}=4.5 to 5.5 V T_A=0 to 70°C or −40 to 85°C		V_{CC}=2.5 to 5.5 V T_A=0 to 70°C or −40 to 85°C		V_{CC}=1.8 to 3.6 V T_A=0 to 70°C or −20 to 85°C[4]		
			Min	Max	Min	Max	Min	Max	
t_{CH1CH2}	t_R	Clock Rise Time		300		300		300	ns
t_{CL1CL2}	t_F	Clock Fall Time		300		300		300	ns
t_{DH1DH2} [2]	t_R	SDA Rise Time	20	300	20	300	20	300	ns
t_{DL1DL2} [2]	t_F	SDA Fall Time	20	300	20	300	20	300	ns
t_{CHDX} [1]	$t_{SU:STA}$	Clock High to Input Transition	600		600		600		ns
t_{CHCL}	t_{HIGH}	Clock Pulse Width High	600		600		600		ns
t_{DLCL}	$t_{HD:STA}$	Input Low to Clock Low (START)	600		600		600		ns
t_{CLDX}	$t_{HD:DAT}$	Clock Low to Input Transition	0		0		0		µs
t_{CLCH}	t_{LOW}	Clock Pulse Width Low	1.3		1.3		1.3		µs
t_{DXCX}	$t_{SU:DAT}$	Input Transition to Clock Transition	100		100		100		ns
t_{CHDH}	$t_{SU:STO}$	Clock High to Input High (STOP)	600		600		600		ns
t_{DHDL}	t_{BUF}	Input High to Input Low (Bus Free)	1.3		1.3		1.3		µs
t_{CLQV} [3]	t_{AA}	Clock Low to Data Out Valid	200	900	200	900	200	900	ns
t_{CLQX}	t_{DH}	Data Out Hold Time After Clock Low	200		200		200		ns
f_C	f_{SCL}	Clock Frequency		400		400		400	kHz
t_W	t_{WR}	Write Time		10		10		10	ms

Note: 1. For a reSTART condition, or following a Write cycle.
2. Sampled only, not 100% tested.
3. To avoid spurious START and STOP conditions, a minimum delay is placed between SCL=1 and the falling or rising edge of SDA.
4. This is preliminary data.

Table 10. AC Measurement Conditions

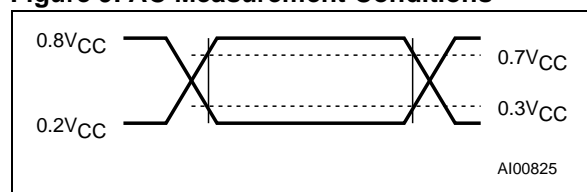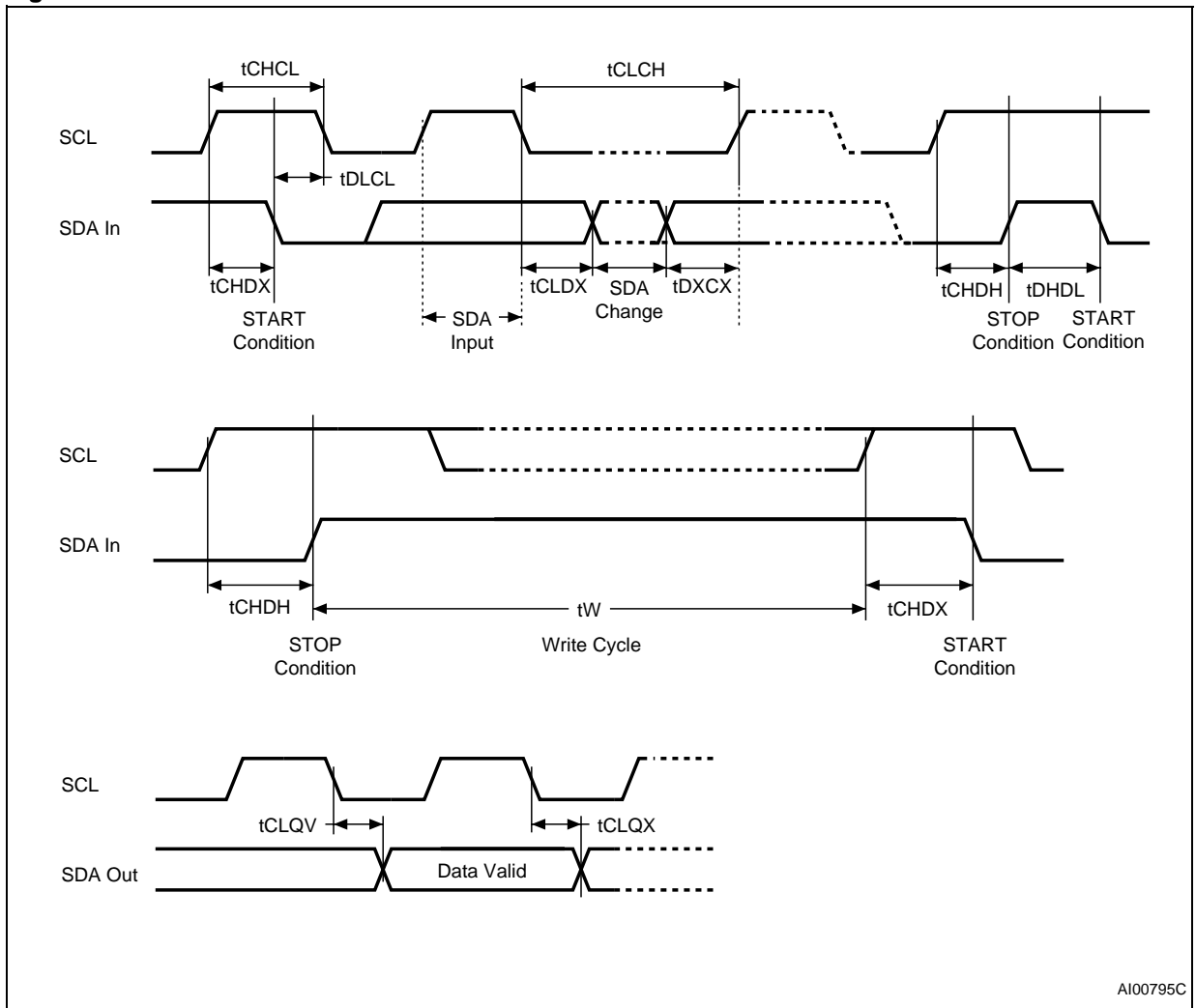| Input Rise and Fall Times	≤ 50 ns
Input Pulse Voltages	$0.2V_{CC}$ to $0.8V_{CC}$
Input and Output Timing Reference Voltages	$0.3V_{CC}$ to $0.7V_{CC}$

Figure 9. AC Measurement Conditions

Figure 10. AC Waveforms

Table 11. Ordering Information Scheme

Example: M24512   –   W   MW   6   T

Memory Capacity		**Option**	
512	512 Kbit (64K x 8)	T	Tape and Reel Packing

Operating Voltage	
blank	4.5 V to 5.5 V
W	2.5 V to 5.5 V
S[1]	1.8 V to 3.6 V

Package		**Temperature Range**	
BN	PDIP8 (0.25 mm frame)	5	–20 °C to 85 °C
MW	SO8 (200 mil width)	6	–40 °C to 85 °C
LA	LGA8 (Land Grid Array)		

Note: 1. The -S version (V_{CC} range 1.8 V to 3.6 V) only available in temperature ranges 5.

ORDERING INFORMATION

Devices are shipped from the factory with the memory content set at all 1s (FFh).

The notation used for the device number is as shown in Table 11. For a list of available options (speed, package, etc.) or for further information on any aspect of this device, please contact your nearest ST Sales Office.

**PDIP8 – 8 pin Plastic DIP, 0.25mm lead frame, Package Outline**
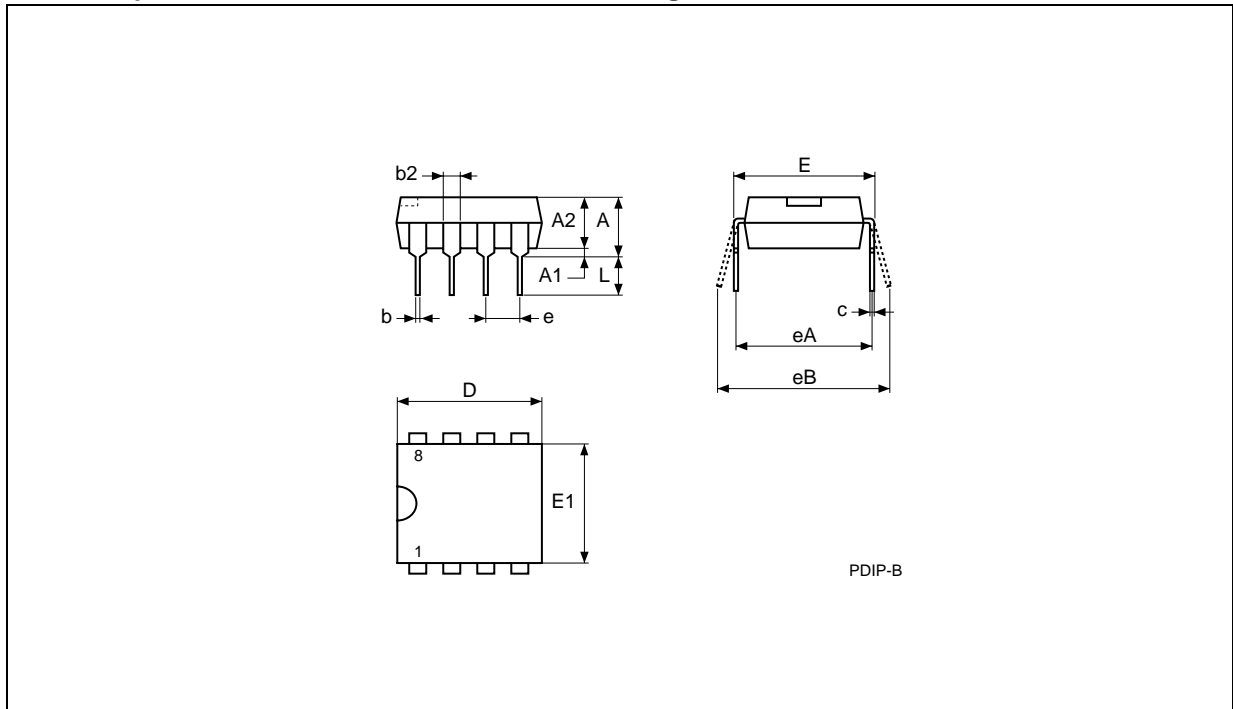
Note: 1. Drawing is not to scale.

PDIP8 – 8 pin Plastic DIP, 0.25mm lead frame, Package Mechanical Data

Symb.	mm			inches		
	Typ.	Min.	Max.	Typ.	Min.	Max.
A			5.33			0.210
A1		0.38			0.015	
A2	3.30	2.92	4.95	0.130	0.115	0.195
b	0.46	0.36	0.56	0.018	0.014	0.022
b2	1.52	1.14	1.78	0.060	0.045	0.070
c	0.25	0.20	0.36	0.010	0.008	0.014
D	9.27	9.02	10.16	0.365	0.355	0.400
E	7.87	7.62	8.26	0.310	0.300	0.325
E1	6.35	6.10	7.11	0.250	0.240	0.280
e	2.54	–	–	0.100	–	–
eA	7.62	–	–	0.300	–	–
eB			10.92			0.430
L	3.30	2.92	3.81	0.130	0.115	0.150

SO8 wide – 8 lead Plastic Small Outline, 200 mils body width

SO-b
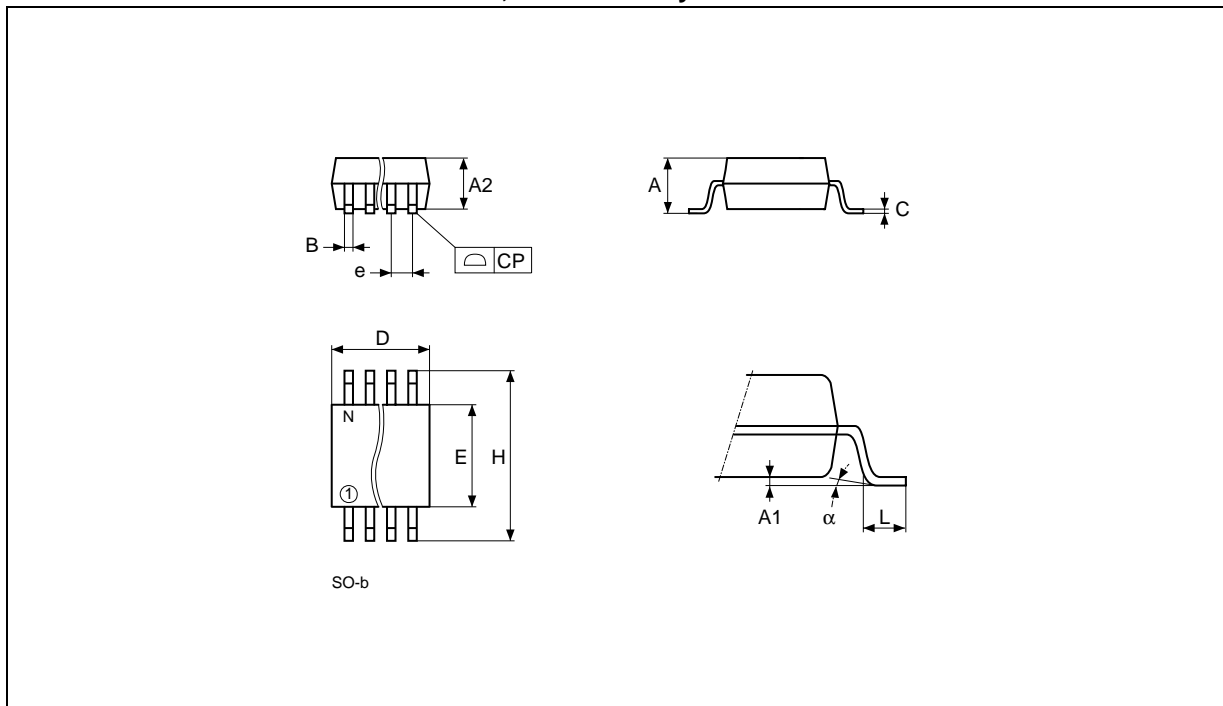
Note: Drawing is not to scale.

SO8 wide – 8 lead Plastic Small Outline, 200 mils body width

Symb.	mm			inches		
	Typ.	Min.	Max.	Typ.	Min.	Max.
A			2.03			0.080
A1		0.10	0.25		0.004	0.010
A2			1.78			0.070
B		0.35	0.45		0.014	0.018
C	0.20	–	–	0.008	–	–
D		5.15	5.35		0.203	0.211
E		5.20	5.40		0.205	0.213
e	1.27	–	–	0.050	–	–
H		7.70	8.10		0.303	0.319
L		0.50	0.80		0.020	0.031
α		0°	10°		0°	10°
N	8			8		
CP			0.10			0.004

LGA8 - 8 lead Land Grid Array
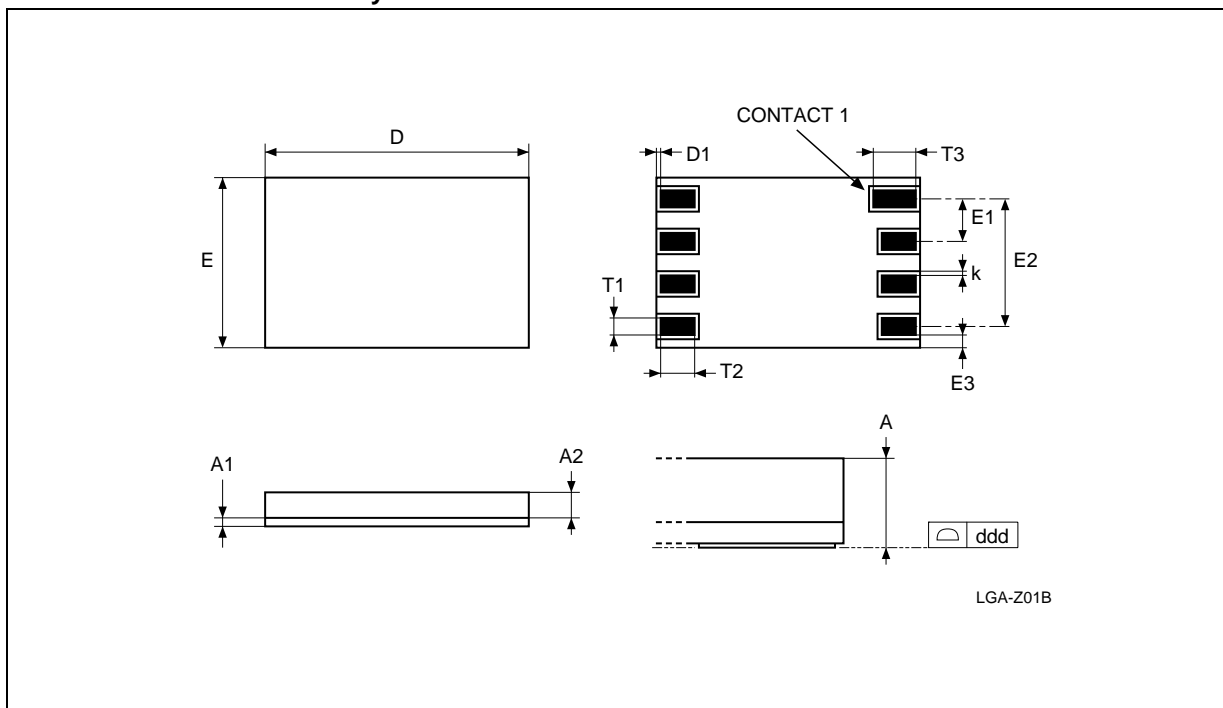
Note: 1. Drawing is not to scale.

LGA8 - 8 lead Land Grid Array

Symb.	mm			inches		
	Typ.	Min.	Max.	Typ.	Min.	Max.
A	1.040	0.940	1.140	0.0409	0.0370	0.0449
A1	0.340	0.300	0.380	0.0134	0.0118	0.0150
A2	0.700	0.640	0.760	0.0276	0.0252	0.0299
D	8.000	7.900	8.100	0.3150	0.3110	0.3189
D1	0.100	–	–	0.0039	–	–
E	5.000	4.900	5.100	0.1969	0.1929	0.2008
E1	1.270	–	–	0.0500	–	–
E2	3.810	–	–	0.1500	–	–
E3	0.390	–	–	0.0154	–	–
k	0.100	–	–	0.0039	–	–
T1	0.410	–	–	0.0161	–	–
T2	0.670	–	–	0.0264	–	–
T3	0.970	–	–	0.0382	–	–
ddd	0.100	–	–	0.0039	–	–

Revision History

Date	Rev.	Description of Revision
29-Jan-2001	1.1	Lead Soldering Temperature in the Absolute Maximum Ratings table amended Write Cycle Polling Flow Chart using ACK illustration updated LGA8 and SO8(wide) packages added References to PSDIP8 changed to PDIP8, and Package Mechanical data updated
10-Apr-2001	1.2	LGA8 Package Mechanical data and illustration updated SO16 package removed
16-Jul-2001	1.3	LGA8 Package given the designator "LA"
02-Oct-2001	1.4	LGA8 Package mechanical data updated
13-Dec-2001	1.5	Document becomes Preliminary Data Test conditions for ILI, ILO, ZL and ZH made more precise VIL and VIH values unified. tNS value changed
12-Jun-2001	1.6	Document becomes Full Datasheet

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